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Kind regards,

Team Nexperia

BUK7L11-34ARC

N-channel TrenchPLUS standard level FET

Rev. 05 — 17 February 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include internal gate resistors and TrenchPLUS diodes for clamping and ElectroStatic Discharge (ESD) protection. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Q101 compliant

 Reduced component count due to integrated gate resistor

1.3 Applications

- 12 V loads
- Automotive systems

- General purpose power switching
- Motors, lamps and solenoids

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I_D	drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	[1] [2]	-	-	89	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	-	172	W
Static ch	naracteristics						
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 30 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 14}}{\text{see } \frac{\text{Figure 6}}{\text{Figure 6}}}$		-	8	11	mΩ

^[1] Current is limited by power dissipation chip rating.

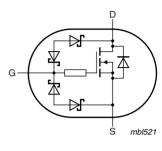


^[2] Refer to document 9397 750 12572 for further information.

Pinning information

Table 2. **Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain	mb	
3	S	source		
mb	D	mounting base; connected to drain	1 2 3	G A



SOT78C (TO-220AB)

Ordering information 3.

Table 3. **Ordering information**

Type number	Package	Package					
	Name	Description	Version				
BUK7L11-34ARC	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-leads	SOT78C				

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

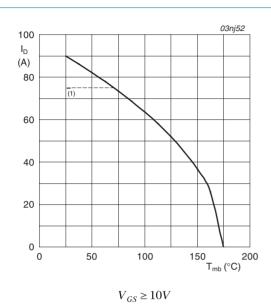
Symbol	Parameter	Conditions		Min	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	[1]	-	34	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	[1]	-	34	V
V_{GS}	gate-source voltage			-20	20	V
I_D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 10 \text{ V}; \text{ see } \frac{\text{Figure 1}}{\text{Figure 1}};$	[2][3]	-	89	Α
		see Figure 3	[4]	-	75	Α
		$T_{mb} = 100 ^{\circ}\text{C}$; $V_{GS} = 10 \text{V}$; see Figure 1		-	63	Α
I_{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10 \mu s$; pulsed; see <u>Figure 3</u>		-	358	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	172	W
$I_{DG(CL)}$	drain-gate clamping current	pulsed; $t_p = 5$ ms; $\delta = 0.01$		-	50	mA
I _{GS(CL)}	gate-source clamping			-	50	mA
	current	continuous		-	10	mA
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-dr	ain diode					
I _S	source current	T _{mb} = 25 °C	[2][3]	-	89	Α
			[4]	-	75	Α
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	358	Α
Avalanche	ruggedness					
E _{DS(CL)S}	non-repetitive drain-source clamping energy	I_D = 60 A; V_{DS} ≤ 34 V; V_{GS} = 10 V; R_{GS} = 50 Ω; unclamped; $T_{j(init)}$ = 25 °C		-	465	mJ
Electrosta	tic discharge					
V _{esd}	electrostatic discharge	HBM; C = 250 pF; R = 1.5 kΩ		-	6	kV
	voltage	HBM; C = 100 pF; R = 1.5 kΩ		-	8	kV

^[1] Voltage is limited by clamping.

^[2] Current is limited by power dissipation chip rating.

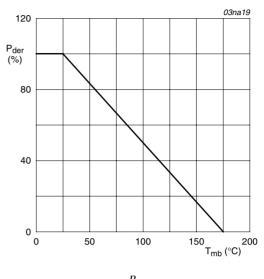
^[3] Refer to document 9397 750 12572 for further information.

^[4] Continuous current is limited by package.



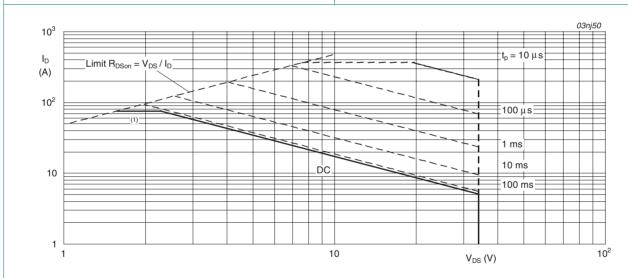
(1) Capped at 75 A due to package

Fig 1. Normalized continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{mb} = 25$ °C; I_{DM} is single pulse

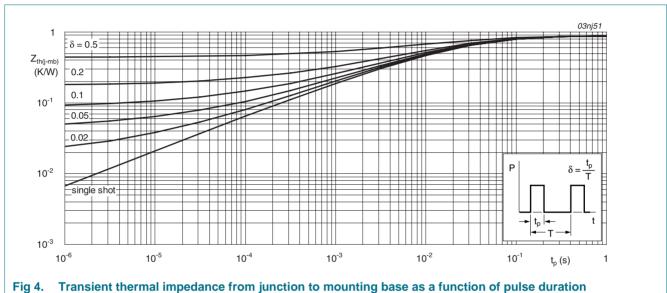
(1) Capped at 75 A due to package

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

Thermal characteristics 5.

Thermal characteristics Table 5.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in free air	-	60	-	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	0.55	0.87	K/W



6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics								
Symbol	Parameter	Conditions	Min	Тур	Max	Unit			
Static cha	racteristics								
$V_{(BR)DG}$	drain-gate (Zener	$I_D = 1 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	34	-	45	V			
	diode) breakdown voltage	$I_D = 1 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	34	-	45	V			
V _{DS(CL)}	drain-source clamping voltage	$I_{GS(CL)}$ = -2 mA; I_D = 1 A; T_j = 25 °C; see <u>Figure 12</u> ; see <u>Figure 18</u>	-	41	-	V			
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 25$ °C; see Figure 13; see Figure 7	2.2	3	3.8	V			
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 150$ °C; see Figure 13; see Figure 7	1.5	-	-	V			
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 175$ °C; see Figure 13; see Figure 7	1.2	-	-	V			
		$I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = -55$ °C; see Figure 13; see Figure 7	-	-	4.2	V			
I _{DSS}	drain leakage current	$V_{DS} = 16 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.1	2	μΑ			
		V _{DS} = 16 V; V _{GS} = 0 V; T _j = 150 °C	-	3	50	μΑ			
		V _{DS} = 16 V; V _{GS} = 0 V; T _j = 175 °C	-	18	250	μΑ			
V _{(BR)GSS} gate-source breakdown voltage		$I_G = 1 \text{ mA}$; $V_{DS} = 0 \text{ V}$; $T_j > -55 \text{ °C}$; $T_j < 175 \text{ °C}$; see Figure 18; see Figure 19	20	22	-	V			
		$I_G = -1 \text{ mA}$; $V_{DS} = 0 \text{ V}$; $T_j > -55 ^{\circ}\text{C}$; $T_j < 175 ^{\circ}\text{C}$; see Figure 18; see Figure 19	20	22	-	V			
lgss	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$	-	5	1000	nA			
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ °C}$	-	5	1000	nA			
		V _{DS} = 0 V; V _{GS} = 10 V; T _j = 175 °C	-	-	50	μΑ			
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 175 ^{\circ}\text{C}$	-	-	50	μΑ			
		V _{DS} = 0 V; V _{GS} = 16 V; T _j = 175 °C	-	-	150	μΑ			
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 30 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 14; see Figure 6	-	8	11	mΩ			
		$V_{GS} = 10 \text{ V}; I_D = 30 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 14; see Figure 6	-	-	20.9	mΩ			
		V _{GS} = 16 V; I _D = 30 A; T _j = 25 °C	-	7	9.7	mΩ			
R_G	internal gate resistance (AC)	f = 1 MHz; T _j = 25 °C	-	11	-	Ω			
Dynamic (characteristics								
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 27 \text{ V}; V_{GS} = 10 \text{ V};$	-	53	-	nC			
Q_{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 16</u>	-	11	-	nC			
Q_{GD}	gate-drain charge		-	20	-	nC			
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	1880	2506	pF			
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 17</u>	-	640	768	pF			
C _{rss}	reverse transfer capacitance		-	400	548	pF			

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$t_{d(on)}$	turn-on delay time	V_{DS} = 30 V; R_L = 1.2 Ω ; V_{GS} = 10 V;	-	20	-	ns
t _r	rise time	$R_{G(ext)} = 10 \Omega$; $T_j = 25 °C$	-	92	-	ns
t _{d(off)}	turn-off delay time		-	127	-	ns
t _f	fall time		-	118	-	ns
L _D	internal drain inductance	measured from contact screw on mounting base to centre of die; $T_j = 25$ °C	-	3.5	-	nΗ
		measured from drain lead 6 mm from package to centre of die; $T_j = 25$ °C	-	4.5	-	nΗ
L _S	internal source inductance	measured from source lead to source bond pad; $T_j = 25 ^{\circ}\text{C}$	-	7.5	-	nΗ
Source-dr	ain diode					
V_{SD}	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 15</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$; $V_{GS} = 0 \text{ V}$;	-	52	-	ns
Qr	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	28	-	nC

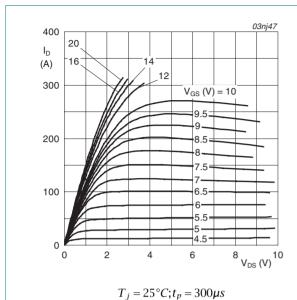
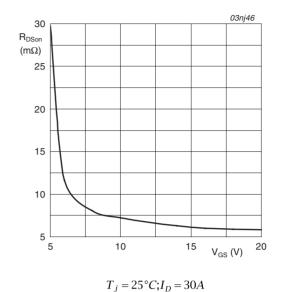
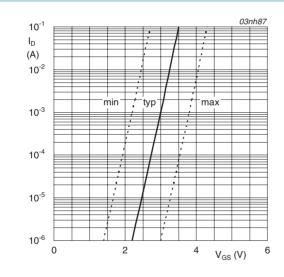


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25$ C, $T_D = 30$ A





 $T_{j}=25\,^{\circ}C; V_{DS}=V_{GS}$ Fig 7. Sub-threshold drain current as a function of

gate-source voltage

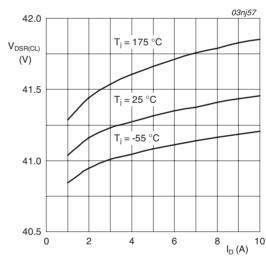
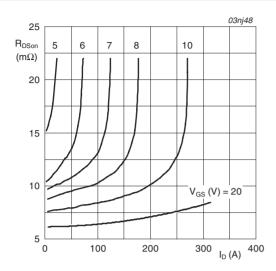


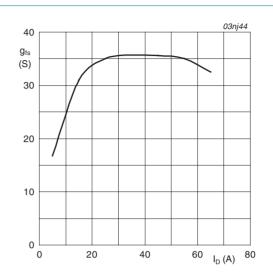
Fig 8. Drain-source clamping voltage as a function of drain current; typical values

 $I_G = -2mA$



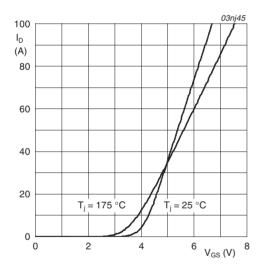
 $T_j = 25^{\circ}C; t_p = 300 \mu s$

Fig 9. Drain-source on-state resistance as a function of drain current; typical values



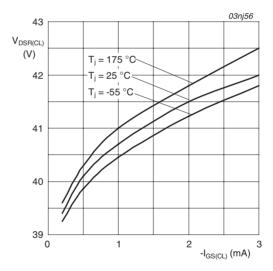
 $T_{j} = 25^{\circ}C; V_{DS} = 25V$

Fig 10. Forward transconductance as a function of drain current; typical values



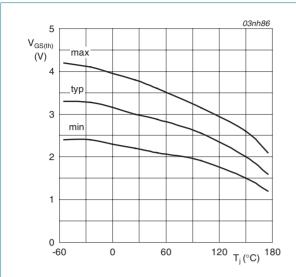
 $V_{DS} = 25V$

Fig 11. Transfer characteristics: drain current as a function of gate-source voltage; typical values



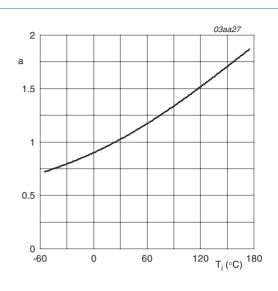
 $I_D = 10A$

Fig 12. Drain-source clamping voltage as a function of gate-source clamping current; typical values



 $I_D = 1mA; V_{DS} = V_{GS}$

Fig 13. Gate-source threshold voltage as a function of junction temperature



$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 14. Normalized drain-source on-state resistance factor as a function of junction temperature

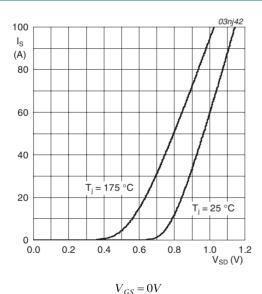
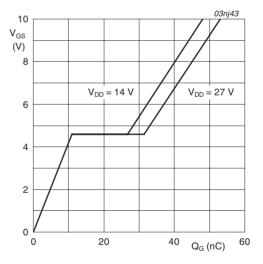
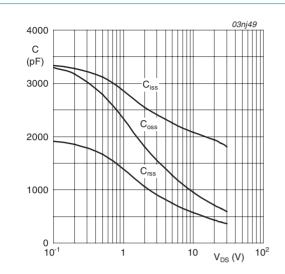


Fig 15. Source current as a function of source-drain voltage; typical values



 $T_i = 25^{\circ}C; I_D = 25A$

Fig 16. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$

Fig 17. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

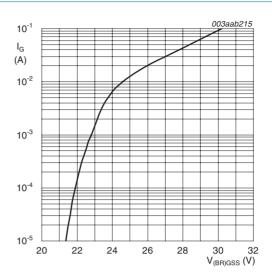


Fig 18. Source-gate clamping current as a function of source-gate clamping voltage; typical values

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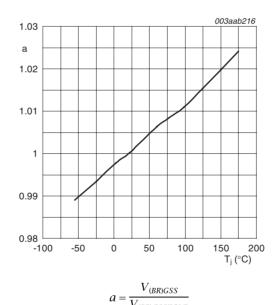
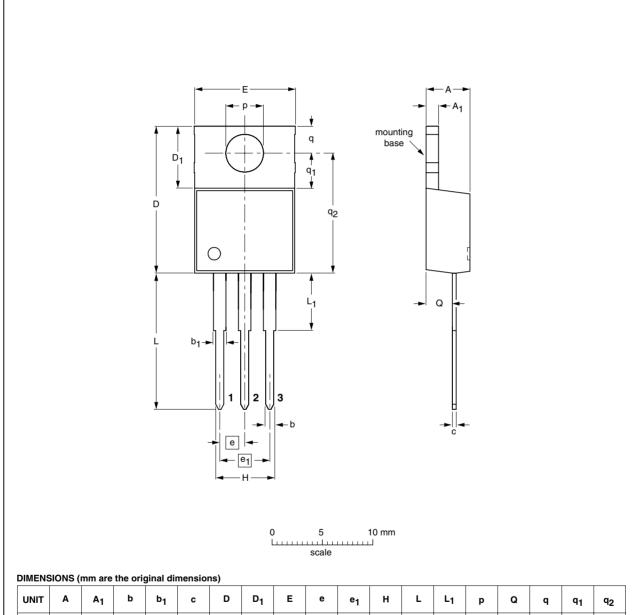


Fig 19. Normalized source-gate clamping voltage as a function of junction temperature; typical values

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3 leads

SOT78C



UNIT	A	A ₁	b	b ₁	С	D	D ₁	E	е	e ₁	Н	L	L ₁	р	Q	q	q ₁	q ₂
mm	4.58	1.33	0.87	1.33	0.44	15.07	6.47	10.40	2.64	5.16	6.03	14.00	6.10	3.90	2.72	2.95	3.80	12.40
	4.31	1.21	0.76	1.21	0.33	14.80	6.22	10.00	2.44	5.00	5.76	13.50	5.58	3.78	2.40	2.69	3.42	12.00

Notes

1. Terminals in this zone are not tinned.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	1330E DATE
SOT78C		3-lead TO-220				01-12-11 03-01-21

Fig 20. Package outline SOT78C (TO-220)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7L11-34ARC_5	20090217	Product data sheet	-	BUK7L11-34ARC_4
Modifications:		of this data sheet has be of NXP Semiconductors.	en redesigned to compl	y with the new identity
	 Legal texts 	have been adapted to the	e new company name v	vhere appropriate.
BUK7L11-34ARC_4	20051216	Product data sheet	-	BUK7L11_34ARC-03
BUK7L11_34ARC-03 (9397 750 12163)	20031203	Product data sheet	-	BUK7L11_34ARC-02
BUK7L11_34ARC-02 (9397 750 11472)	20030522	Product data sheet	-	BUK7L11_34ARC-01
BUK7L11_34ARC-01 (9397 750 11178)	20030423	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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BUK7L11-34ARC

N-channel TrenchPLUS standard level FET

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